# Power MOSFET Dual P-Channel ChipFET™

# 3.0 Amps, 8 Volts

#### **Features**

- Low R<sub>DS(on)</sub> for Higher Efficiency
- Logic Level Gate Drive
- Miniature ChipFET Surface Mount Package

#### **Applications**

• Power Management in Portable and Battery–Powered Products; i.e., Cellular and Cordless Telephones and PCMCIA Cards

#### **MAXIMUM RATINGS** ( $T_A = 25^{\circ}C$ unless otherwise noted)

Rating	Symbol	5 secs	Steady State	Unit
Drain-Source Voltage	V <sub>DS</sub>	-8.0		V
Gate-Source Voltage	V <sub>GS</sub>	±8.0		V
Continuous Drain Current $(T_J = 150^{\circ}C)$ (Note 1) $T_A = 25^{\circ}C$ $T_A = 85^{\circ}C$	I <sub>D</sub>	±4.1 ±2.9	±3.0 ±2.2	А
Pulsed Drain Current	I <sub>DM</sub>	±10		Α
Continuous Source Current (Diode Conduction) (Note 1)	I <sub>S</sub>	-1.8	-0.9	Α
Maximum Power Dissipation (Note 1)  T <sub>A</sub> = 25°C  T <sub>A</sub> = 85°C	P <sub>D</sub>	2.1 1.1	1.1 0.6	W
Operating Junction and Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	-55 to +150		°C

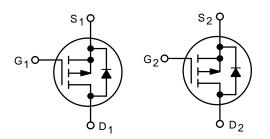
1. Surface Mounted on 1" x 1" FR4 Board.



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DUAL P-CHANNEL 3.0 AMPS, 8 VOLTS  $R_{DS(on)} = 90 \text{ m}\Omega$ 

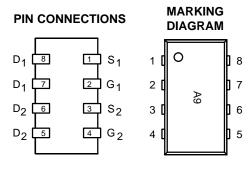


P-Channel MOSFET

P-Channel MOSFET



ChipFET CASE 1206A STYLE 2



A9 = Specific Device Code

#### **ORDERING INFORMATION**

Device	Package	Shipping		
NTHD5905T1	ChipFET	3000/Tape & Reel		

#### THERMAL CHARACTERISTICS

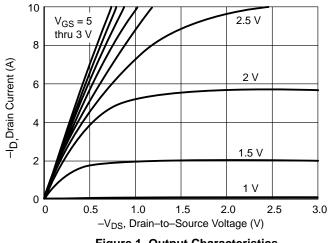
Characteristic	Symbol	Тур	Max	Unit
$\label{eq:maximum Junction-to-Ambient (Note 2)} \begin{split} &t \leq 5 \text{ sec} \\ &\text{Steady State} \end{split}$	R <sub>thJA</sub>	50 90	60 110	°C/W
Maximum Junction-to-Foot (Drain) Steady State	R <sub>thJF</sub>	30	40	°C/W

# **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise noted)

Characteristic	Symbol	Test Condition	Min	Тур	Max	Unit
Static	•		•		•	
Gate Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	-0.45	-	_	V
Gate-Body Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 8.0 \text{ V}$	-	-	±100	nA
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{DS} = -6.4 \text{ V}, V_{GS} = 0 \text{ V}$	-	-	-1.0	μΑ
		$V_{DS} = -6.4 \text{ V}, V_{GS} = 0 \text{ V},$ $T_{J} = 85^{\circ}\text{C}$	-	-	-5.0	
On-State Drain Current (Note 3)	I <sub>D(on)</sub>	$V_{DS} \le -5.0 \text{ V}, V_{GS} = -4.5 \text{ V}$	-10	-	_	Α
Drain-Source On-State Resistance (Note 3)	r <sub>DS(on)</sub>	$V_{GS} = -4.5 \text{ V}, I_D = -3.0 \text{ A}$	-	0.075	0.090	Ω
		$V_{GS} = -2.5 \text{ V}, I_D = -2.5 \text{ A}$	_	0.110	0.130	
		$V_{GS} = -1.8 \text{ V}, I_D = -1.0 \text{ A}$	_	0.150	0.180	
Forward Transconductance (Note 3)	9 <sub>fs</sub>	$V_{DS} = -5.0 \text{ V}, I_{D} = -3.0 \text{ A}$	_	7.0	_	S
Diode Forward Voltage (Note 3)	V <sub>SD</sub>	$I_S = -0.9 \text{ A}, V_{GS} = 0 \text{ V}$	-	-0.8	-1.2	V
Dynamic (Note 4)						
Total Gate Charge	Qg		-	5.5	9.0	nC
Gate-Source Charge	Q <sub>gs</sub>	$V_{DS} = -4.0 \text{ V}, V_{GS} = -4.5 \text{ V},$ $I_{D} = -3.0 \text{ A}$	_	0.5	_	
Gate-Drain Charge	Q <sub>gd</sub>		_	1.5	_	
Turn-On Delay Time	t <sub>d(on)</sub>		-	10	15	ns
Rise Time	t <sub>r</sub>	$V_{DD} = -4.0 \text{ V}, R_{L} = 4 \Omega$	_	45	70	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong -1.0 \text{ A}, V_{GEN} = -4.5 \text{ V},$ $R_G = 6 \Omega$	_	30	45	
Fall Time	t <sub>f</sub>		_	10	15	
Source-Drain Reverse Recovery Time	trr	I <sub>E</sub> = -0.9 A, di/dt = 100 A/μs	_	30	60	ĺ

Surface Mounted on 1" x 1" FR4 Board.
 Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
 Guaranteed by design, not subject to production testing.

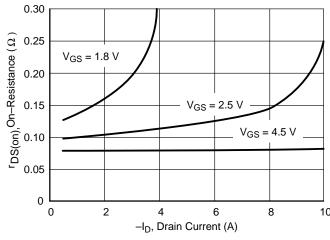
#### TYPICAL ELECTRICAL CHARACTERISTICS



10  $T_C = -55^{\circ}C$ 25°C 8 -I<sub>D</sub>, Drain Current (A) 125°C 6 2 0 0 0.5 1.5 2.0 3.0 -V<sub>GS</sub>, Gate-to-Source Voltage (V)

Figure 1. Output Characteristics

Figure 2. Transfer Characteristics



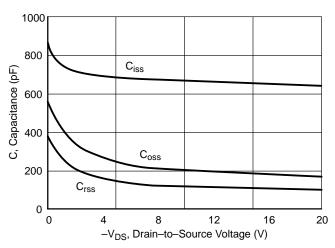
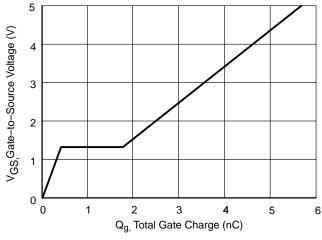


Figure 3. On-Resistance vs. Drain Current

Figure 4. Capacitance



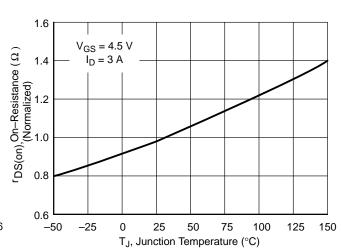
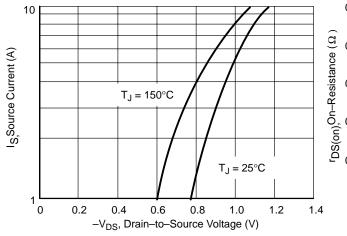


Figure 5. Gate Charge

Figure 6. On-Resistance vs. **Junction Temperature** 

#### TYPICAL ELECTRICAL CHARACTERISTICS

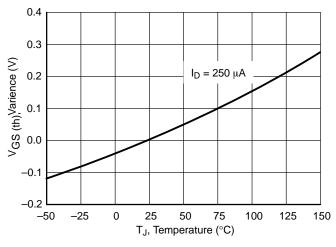
50



0.25  $\widehat{G}$  0.20 0.15 0.15 0.10 0 1 2 3 4 5  $-V_{GS}$ , Gate—to—Source Voltage (V)

Figure 7. Source Diode Forward Voltage

Figure 8. On-Resistance vs. Gate-to-Source Voltage



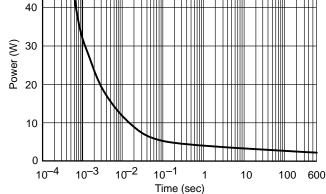


Figure 9. Threshold Voltage

Figure 10. Single Pulse Power

### TYPICAL ELECTRICAL CHARACTERISTICS

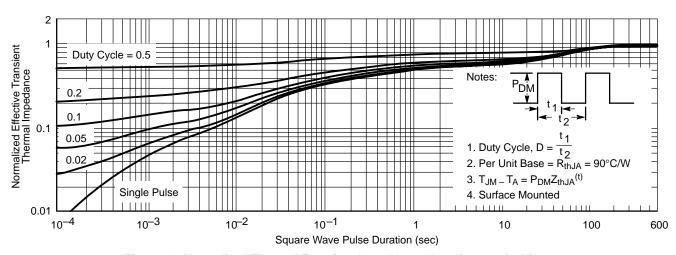


Figure 11. Normalized Thermal Transient Impedance, Junction-to-Ambient

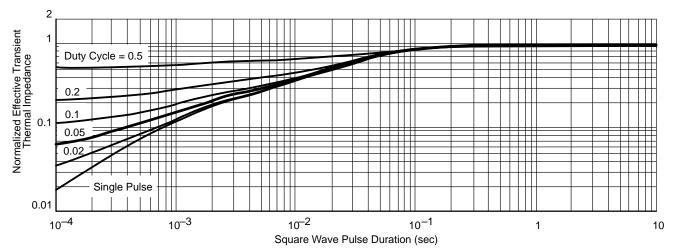
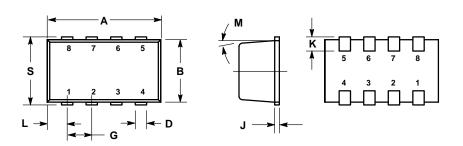


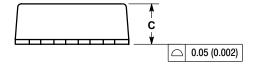
Figure 12. Normalized Thermal Transient Impedance, Junction-to-Foot

# **Notes**

#### **PACKAGE DIMENSIONS**

#### ChipFET CASE 1206A-03 ISSUE D





STYLE 2:
PIN 1. SOURCE 1
2. GATE 1
3. SOURCE 2
4. GATE 2
5. DRAIN 2
6. DRAIN 2
7. DRAIN 1
8. DRAIN 1

- NOTES:
  1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
  2. CONTROLLING DIMENSION: MILLIMETER.
  3. MOLD GATE BURRS SHALL NOT EXCEED 0.13 MM PER SIDE.
  4. LEADFRAME TO MOLDED BODY OFFSET IN HORIZONTAL AND VERTICAL SHALL NOT EXCEED 0.08 MM.
  5. DIMENSIONS A AND B EXCLUSIVE OF MOLD GATE BURRS.
  6. NO MOLD FLASH ALLOWED ON THE TOP AND BOTTOM LEAD SURFACE.
  7. 1206A-01 AND 1206A-02 OBSOLETE. NEW STANDARD IS 1206A-03.

	MILLIMETERS		INCHES		
DIM	MIN	MAX	MIN	MAX	
Α	2.95	3.10	0.116	0.122	
В	1.55	1.70	0.061	0.067	
С	1.00	1.10	0.039	0.043	
D	0.25	0.35	0.010	0.014	
G	0.65 BSC		0.025 BSC		
J	0.10	0.20	0.004	0.008	
K	0.28	0.42	0.011	0.017	
L	0.55	BSC	0.022 BSC		
M	5 °	5° NOM		5 ° NOM	
S	1.80	2.00	0.072	0.080	

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